

**Notice of References Cited**

Application/Control No.

10/052,160

Applicant(s)/Patent Under  
Reexamination  
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,855,206	10-1958	Haviland, G. S.	279/46.7
	B	US-3,688,635	09-1972	Fegen, James	174/138A
	C	US-3,733,655	05-1973	Kolibar, Richard W.	403/408.1
	D	US-3,764,729	10-1973	Kowalewski, Edward C.	174/138D
	E	US-3,777,052	12-1973	Fegen, James F.	174/138D
	F	US-3,811,154	05-1974	Lindeman et al.	24/326
	G	US-3,836,703	09-1974	Coules, Ronald A.	174/138D
	H	US-4,012,155	03-1977	Morris, Max O.	403/290
	I	US-4,149,764	04-1979	Mattingly, Jr., William R.	439/75
	J	US-4,200,900	04-1980	McGeorge, Gram	361/803
	K	US-4,363,530	12-1982	Verhoeven, Laurentius M.	439/557
	L	US-4,427,316	01-1984	Moore et al.	403/2
	M	US-4,495,548	01-1985	Matsui, Kazuhiro	361/790

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-0 611 002 A1	08-1994	EPO	Ferrari et al.	F16B 12/10
	O	GB-2 032 202 A	04-1980	GB	Normann, Richard W.	H01R 13/33
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,502,193	03-1985	Harmon et al.	24/621
	B	US-4,544,217	10-1985	Denny, Alan	439/64
	C	US-4,640,639	02-1987	Matsui, Kazuhiro	403/24
	D	US-4,664,458	05-1987	Worth, Sidney V.	439/82
	E	US-D290,929	07-1987	Hill, Royce W.	D8/354
	F	US-D291,278	08-1987	Hill, Royce W.	D8/354
	G	US-D295,369	04-1988	Niwa, Katsumi	D8/354
	H	US-4,776,811	10-1988	Humphrey, David T.	439/378
	I	US-4,797,113	01-1989	Lambert, Roger T.	439/74
	J	US-4,875,140	10-1989	Delpech et al.	361/789
	K	US-4,903,603	02-1990	Longerich et al.	102/293
	L	US-4,938,703	07-1990	Nakano, Yoshihito	439/74
	M	US-4,969,065	11-1990	Petri, Hector D.	361/804

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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**NON-PATENT DOCUMENTS**

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	U	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,970,761	11-1990	Nakamura, Toshinobu	24/453
	B	US-5,014,419	05-1991	Cray et al.	29/830
	C	US-5,018,982	05-1991	Speraw et al.	439/74
	D	US-5,106,310	04-1992	Krajewski et al.	439/75
	E	US-5,112,232	05-1992	Cray et al.	439/75
	F	US-5,129,830	07-1992	Krajewski et al.	439/75
	G	US-5,135,403	08-1992	Rinaldi, John A.	439/82
	H	US-5,147,227	09-1992	Yurko, Garold M.	439/733.1
	I	US-5,152,696	10-1992	Krajewski et al.	439/75
	J	US-5,254,016	10-1993	Ganthier, James J.	439/567
	K	US-5,266,912	11-1993	Kledzik, Kenneth J.	333/247
	L	US-5,316,487	05-1994	Clark, Stephen L.	439/78
	M	US-5,411,400	05-1995	Subrahmanyam et al.	439/68

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,548,486	08-1996	Kman et al.	361/791
	B	US-5,715,595	02-1998	Kman et al.	29/845
	C	US-5,878,483	03-1999	Kman et al.	29/739
	D	US-6,225,566 B1	05-2001	Dienst, Richard L.	174/138E
	E	US-6,241,531 B1	06-2001	Roath et al.	439/66
	F	US-6,305,949 B1	10-2001	Okuyama et al.	439/75
	G	US-6,319,058 B1	11-2001	Jones, Dennis B.	439/567
	H	US-6,333,855 B2	12-2001	Prabaonnaud et al.	361/758
	I	US-6,503,090 B2	01-2003	Onizuka, Takahiro	439/75
	J	US-6,543,098 B2	04-2003	Meyer et al.	24/289
	K	US-6,545,228 B2	04-2003	Hashimoto, Nobuaki	174/260
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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